# Field Stop Trench IGBT
## 650 V, 75 A
# FGHL75T65MQD

| $BV_{CES}$ | $V_{CE(sat)}$ TYP | $I_C$ MAX |
|---|---|---|
| 650 V | 1.45 V | 75 A |

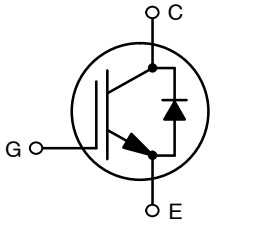
Field stop 4th generation mid speed IGBT technology and Full current rated copak Diode technology.

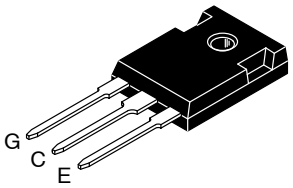
### Features

- Maximum Junction Temperature: $T_J$ = 175°C
- Positive Temperature Co−efficient for Easy Parallel Operating
- High Current Capability
- Low Saturation Voltage: $V_{CE(sat)}$ = 1.45 V (Typ.) @ $I_C$ = 75 A
- 100% of the Parts are Tested for $I_{LM}$ (Note 2)
- Smooth & Optimized Switching
- Tight Parameter Distribution
- RoHS Compliant

### Typical Applications

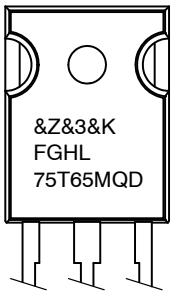
- Solar Inverter
- UPS, ESS
- PFC, Converters




**TO−247 LONG LEADS**
**CASE 340CX**

### MARKING DIAGRAM




| | |
|---|---|
| &Z | = Assembly Plant Code |
| &3 | = 3−Digit Date Code |
| &K | = 2−Digit Lot Traceability Code |
| FGHL75T65MQD | = Specific Device Code |

### MAXIMUM RATINGS

| Parameter | | Symbol | Value | Unit |
|---|---|---|---|---|
| Collector−to−Emitter Voltage | | $V_{CES}$ | 650 | V |
| Gate−to−Emitter Voltage | | $V_{GES}$ | ±20 | V |
| Transient Gate−to−Emitter Voltage | | $V_{GES}$ | ±30 | V |
| Collector Current (Note 1) | $T_C$ = 25°C | $I_C$ | 80 | A |
| | $T_C$ = 100°C | | 75 | |
| Pulsed Collector Current (Note 2) | | $I_{LM}$ | 300 | A |
| Pulsed Collector Current (Note 3) | | $I_{CM}$ | 300 | A |
| Diode Forward Current (Note 1) | $T_C$ = 25°C | $I_F$ | 80 | A |
| | $T_C$ = 65°C | | 75 | |
| Pulsed Diode Maximum Forward Current | | $I_{FM(2)}$ | 300 | A |
| Non−Repetitive Forward Surge Current (Half−Sine Pulse, $t_p$ = 8.3 ms, $T_C$ = 25°C) (Half−Sine Pulse, $t_p$ = 8.3 ms, $T_C$ = 150°C) | | $I_{F,SM}$ | 255 225 | A |
| Maximum Power Dissipation | $T_C$ = 25°C | $P_D$ | 375 | W |
| | $T_C$ = 100°C | | 188 | |
| Operating Junction and Storage Temperature Range | | $T_J$, $T_{stg}$ | −55 to +175 | °C |
| Maximum Lead Temperature for Soldering Purposes (1/8″ from case for 5 s) | | $T_L$ | 260 | °C |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Value limit by bond wire
2. $V_{CC}$ = 400 V, $V_{GE}$ = 15 V, $I_C$ = 300 A, $R_G$ = 14 Ω, Inductive Load, 100% Tested
3. Repetitive rating: Pulse width limited by max. junction temperature

### ORDERING INFORMATION

| Device | Package | Shipping |
|---|---|---|
| FGHL75T65MQD | TO−247−3L | 30 Units / Rail |

**Table 1. THERMAL CHARACTERISTICS**

| Parameter | Symbol | Value | Unit |
|---|---|---|---|
| Thermal Resistance Junction−to−Case, for IGBT | $R_{\theta JC}$ | 0.40 | °C/W |
| Thermal Resistance Junction−to−Case, for Diode | $R_{\theta JC}$ | 0.6 | |
| Thermal Resistance Junction−to−Ambient | $R_{\theta JA}$ | 40 | |

**Table 2. ELECTRICAL CHARACTERISTICS** ($T_J$ = 25°C unless otherwise specified)

| Parameter | Test Conditions | Symbol | Min | Typ | Max | Unit |
|---|---|---|---|---|---|---|
| **OFF CHARACTERISTIC** | | | | | | |
| Collector−emitter breakdown voltage, gate−emitter short−circuited | $V_{GE}$ = 0 V, $I_C$ = 1 mA | $BV_{CES}$ | 650 | – | – | V |
| Temperature Coefficient of Breakdown Voltage | $V_{GE}$ = 0 V, $I_C$ = 1 mA | $\Delta BV_{CES}/\Delta T_J$ | – | 0.6 | – | V/°C |
| Collector−emitter cut−off current, gate−emitter short−circuited | $V_{GE}$ = 0 V, $V_{CE}$ = 650 V | $I_{CES}$ | – | – | 250 | μA |
| Gate leakage current, collector−emitter short−circuited | $V_{GE}$ = 20 V, $V_{CE}$ = 0 V | $I_{GES}$ | – | – | ±400 | nA |
| **ON CHARACTERISTIC** | | | | | | |
| Gate−emitter threshold voltage | $V_{GE}$ = $V_{CE}$, $I_C$ = 75 mA | $V_{GE(th)}$ | 3.0 | 4.5 | 6.0 | V |
| Collector−emitter saturation voltage | $V_{GE}$ = 15 V, $I_C$ = 75 A<br>$V_{GE}$ = 15 V, $I_C$ = 75 A, $T_J$ = 175°C | $V_{CE(sat)}$ | –<br>– | 1.45<br>1.65 | 1.8<br>– | V |
| **DYNAMIC CHARACTERISTIC** | | | | | | |
| Input capacitance | $V_{CE}$ = 30 V, $V_{GE}$ = 0 V, f = 1 MHz | $C_{ies}$ | – | 4913 | – | pF |
| Output capacitance | | $C_{oes}$ | – | 131 | – | |
| Reverse transfer capacitance | | $C_{res}$ | – | 15 | – | |
| Gate charge total | $V_{CE}$ = 400 V, $I_C$ = 75 A, $V_{GE}$ = 15 V | $Q_g$ | – | 145 | – | nC |
| Gate−to−Emitter charge | | $Q_{ge}$ | – | 25 | – | |
| Gate−to−Collector charge | | $Q_{gc}$ | – | 33 | – | |
| **SWITCHING CHARACTERISTIC, INDUCTIVE LOAD** | | | | | | |
| Turn−on delay time | $T_C$ = 25°C<br>$V_{CC}$ = 400 V, $I_C$ = 37.5 A<br>$R_G$ = 10 Ω<br>$V_{GE}$ = 15 V<br>Inductive Load | $t_{d(on)}$ | – | 29 | – | ns |
| Rise time | | $t_r$ | – | 29 | – | |
| Turn−off delay time | | $t_{d(off)}$ | – | 193 | – | |
| Fall time | | $t_f$ | – | 47 | – | |
| Turn−on switching loss | | $E_{on}$ | – | 0.75 | – | mJ |
| Turn−off switching loss | | $E_{off}$ | – | 0.48 | – | |
| Total switching loss | | $E_{ts}$ | – | 1.22 | – | |
| Turn−on delay time | $T_C$ = 25°C<br>$V_{CC}$ = 400 V, $I_C$ = 75 A<br>$R_G$ = 10 Ω<br>$V_{GE}$ = 15 V<br>Inductive Load | $t_{d(on)}$ | – | 33 | – | ns |
| Rise time | | $t_r$ | – | 60 | – | |
| Turn−off delay time | | $t_{d(off)}$ | – | 176 | – | |
| Fall time | | $t_f$ | – | 76 | – | |
| Turn−on switching loss | | $E_{on}$ | – | 1.94 | – | mJ |
| Turn−off switching loss | | $E_{off}$ | – | 1.55 | – | |
| Total switching loss | | $E_{ts}$ | – | 3.49 | – | |

**Table 2. ELECTRICAL CHARACTERISTICS** ($T_J$ = 25°C unless otherwise specified) (continued)

| Parameter | Test Conditions | Symbol | Min | Typ | Max | Unit |
|---|---|---|---|---|---|---|
| **SWITCHING CHARACTERISTIC, INDUCTIVE LOAD** | | | | | | |
| Turn−on delay time | $T_C$ = 175°C<br>$V_{CC}$ = 400 V, $I_C$ = 37.5 A<br>$R_G$ = 10 Ω<br>$V_{GE}$ = 15 V<br>Inductive Load | $t_{d(on)}$ | − | 27 | − | ns |
| Rise time | | $t_r$ | − | 31 | − | |
| Turn−off delay time | | $t_{d(off)}$ | − | 214 | − | |
| Fall time | | $t_f$ | − | 66 | − | |
| Turn−on switching loss | | $E_{on}$ | − | 1.49 | − | mJ |
| Turn−off switching loss | | $E_{off}$ | − | 0.72 | − | |
| Total switching loss | | $E_{ts}$ | − | 2.21 | − | |
| Turn−on delay time | $T_C$ = 175°C<br>$V_{CC}$ = 400 V, $I_C$ = 75 A<br>$R_G$ = 10 Ω<br>$V_{GE}$ = 15 V<br>Inductive Load | $t_{d(on)}$ | − | 31 | − | ns |
| Rise time | | $t_r$ | − | 61 | − | |
| Turn−off delay time | | $t_{d(off)}$ | − | 191 | − | |
| Fall time | | $t_f$ | − | 85 | − | |
| Turn−on switching loss | | $E_{on}$ | − | 3.23 | − | mJ |
| Turn−off switching loss | | $E_{off}$ | − | 1.90 | − | |
| Total switching loss | | $E_{ts}$ | − | 5.12 | − | |
| **DIODE CHARACTERISTIC** | | | | | | |
| Diode Forward Voltage | $I_F$ = 75 A, $T_C$ = 25°C<br>$I_F$ = 75 A, $T_C$ = 175°C | $V_{FM}$ | −<br>− | 2.3<br>1.9 | 2.6<br>− | V |
| Reverse Recovery Energy | $I_F$ = 75 A, $dI_F/dt$ = 200 A/μs, $T_C$ = 175°C | $E_{rec}$ | − | 49 | − | μJ |
| Diode Reverse Recovery Time | $I_F$ = 75 A, $dI_F/dt$ = 200 A/μs, $T_C$ = 25°C<br>$I_F$ = 75 A, $dI_F/dt$ = 200 A/μs, $T_C$ = 175°C | $T_{rr}$ | − | 36<br>204 | − | ns |
| Diode Reverse Recovery Charge | $I_F$ = 75 A, $dI_F/dt$ = 200 A/μs, $T_C$ = 25°C<br>$I_F$ = 75 A, $dI_F/dt$ = 200 A/μs, $T_C$ = 175°C | $Q_{rr}$ | − | 51<br>990 | − | nC |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

## TYPICAL CHARACTERISTICS

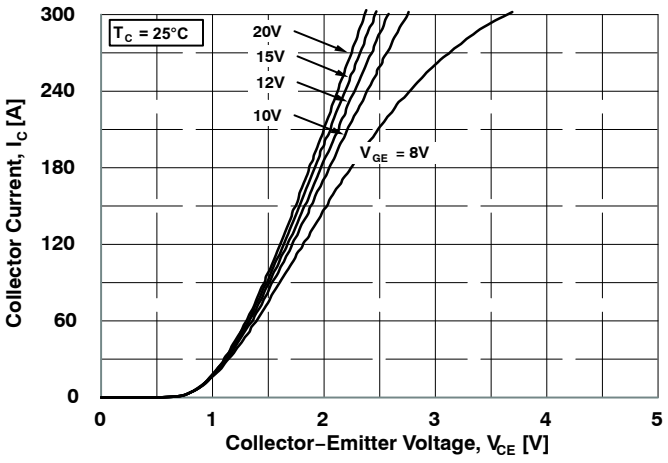



Figure 1. Typical Output Characteristics (25°C)

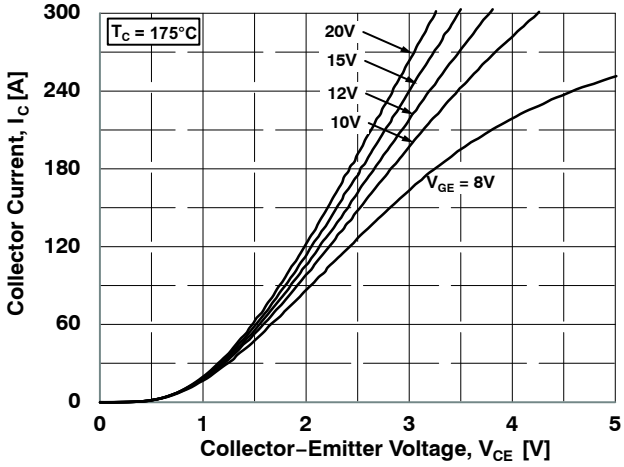



Figure 2. Typical Output Characteristics (175°C)

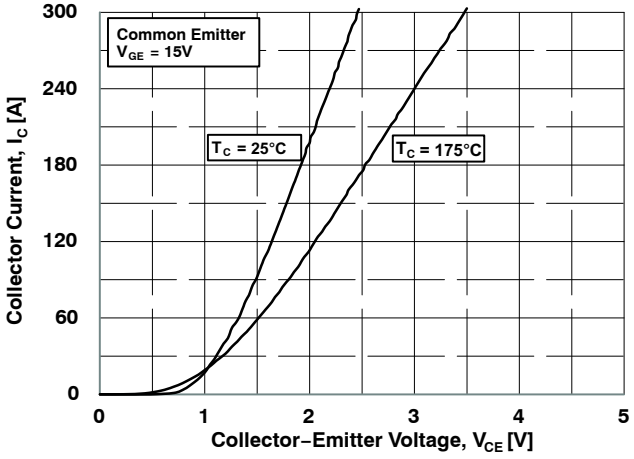



Figure 3. Typical Saturation Voltage Characteristics

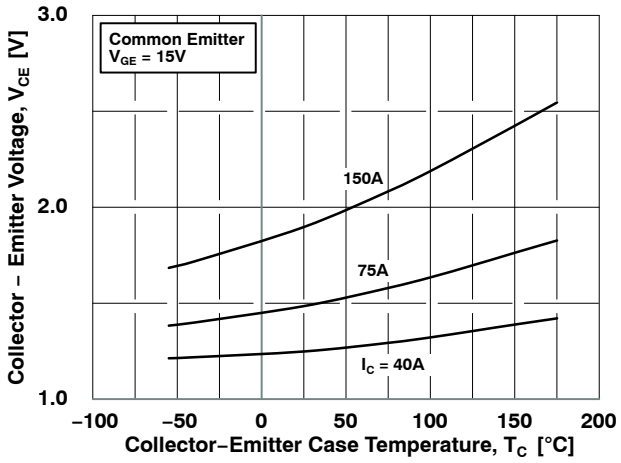



Figure 4. Saturation Voltage vs. Case Temperature at Variant Current Level

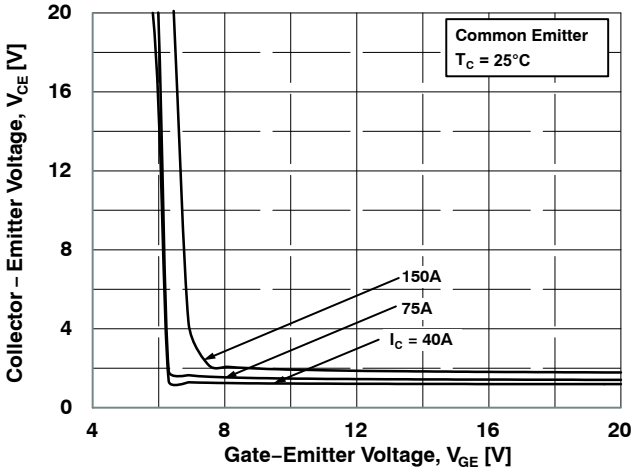



Figure 5. Saturation Voltage vs. $V_{GE}$ (25°C)

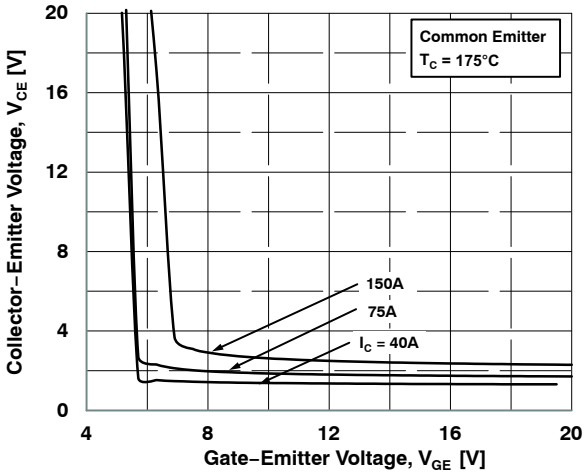



Figure 6. Saturation Voltage vs. $V_{GE}$ (175°C)

## TYPICAL CHARACTERISTICS

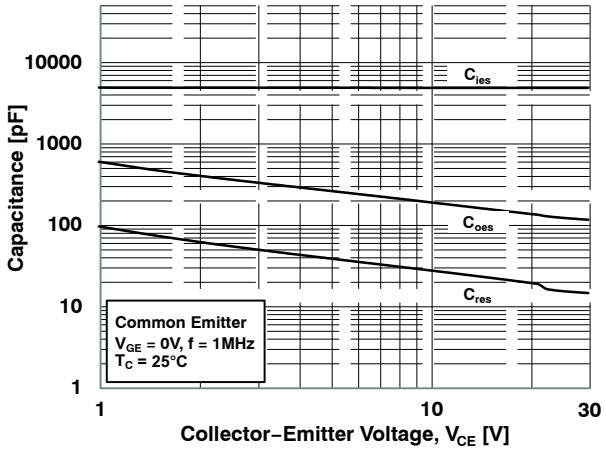



Figure 7. Capacitance Characteristics

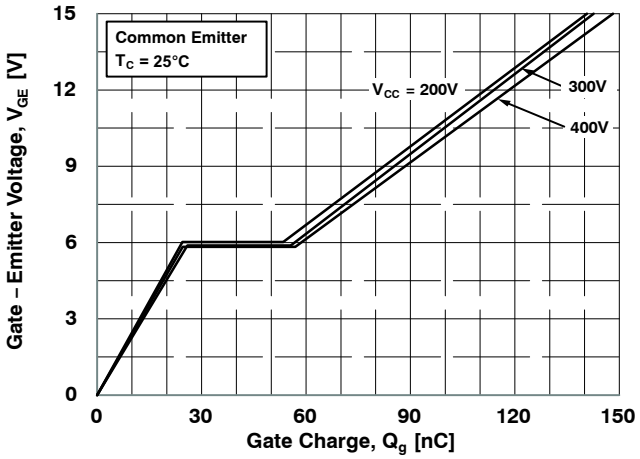



Figure 8. Gate Charge Characteristics

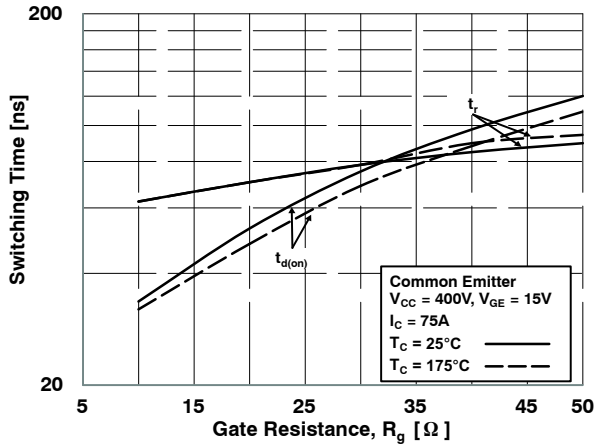



Figure 9. Turn−On Characteristics vs. Gate Resistance

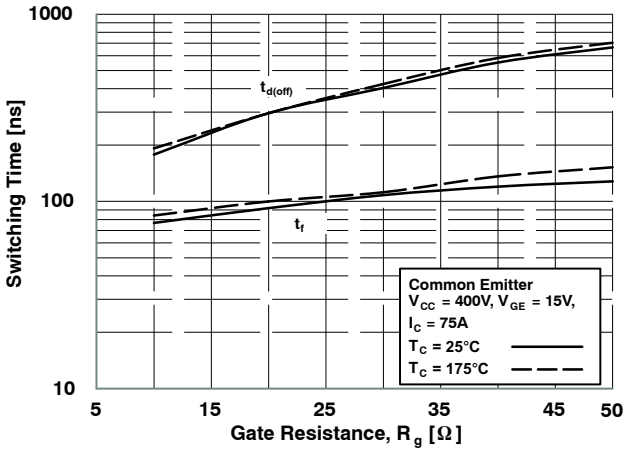



Figure 10. Turn−Off Characteristics vs. Gate Resistance

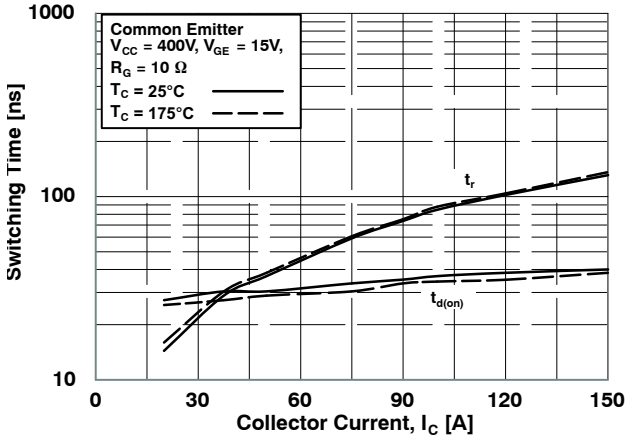



Figure 11. Turn−On Characteristics vs. Collector Current

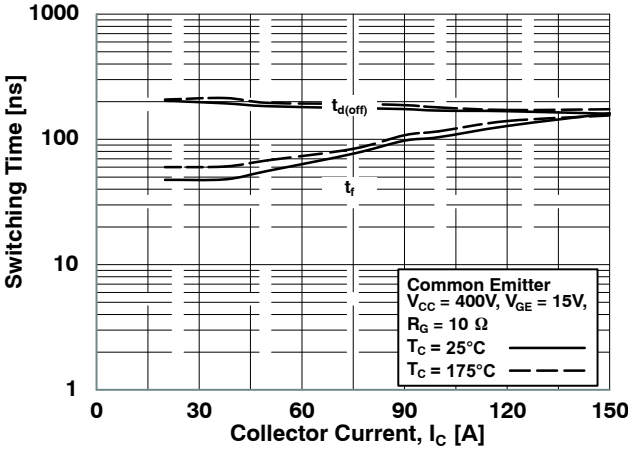



Figure 12. Turn−Off Characteristics vs. Collector Current

## TYPICAL CHARACTERISTICS

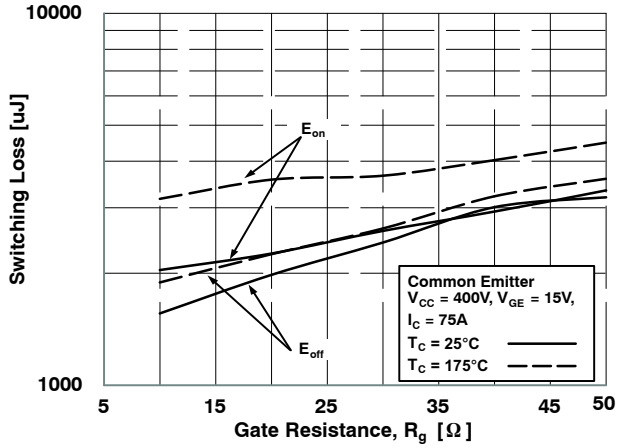



Figure 13. Switching Loss vs. Gate Resistance

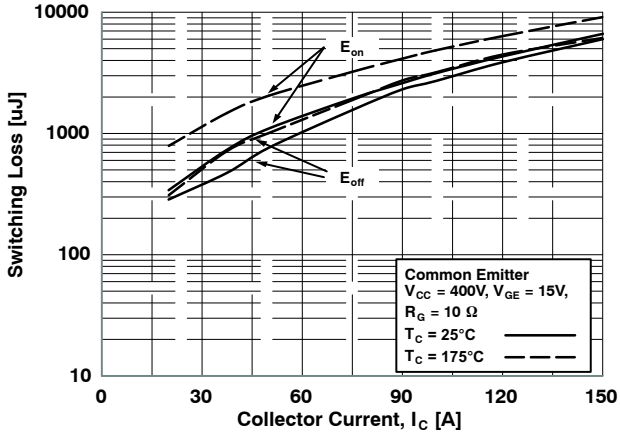



Figure 14. Switching Loss vs. Collector Current

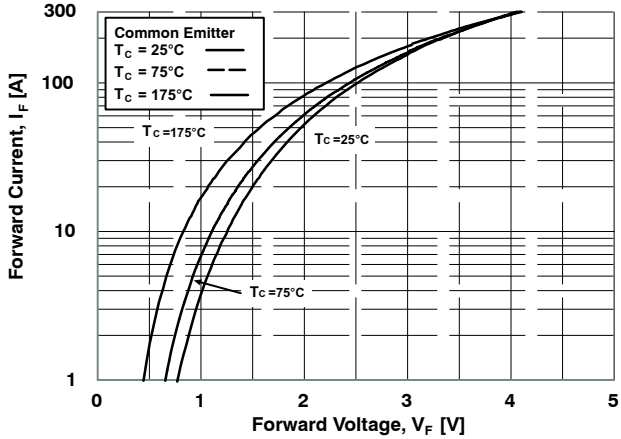



Figure 15. Forward Characteristics

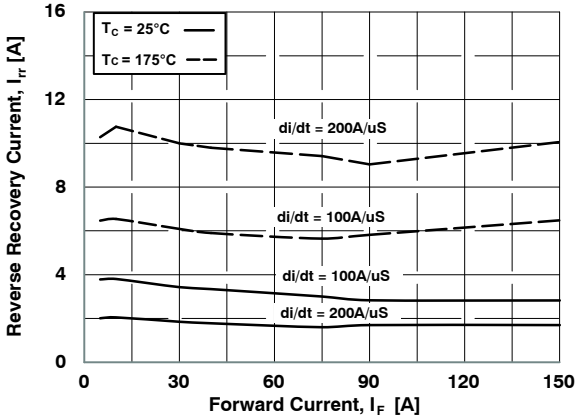



Figure 16. Reverse Recovery Current

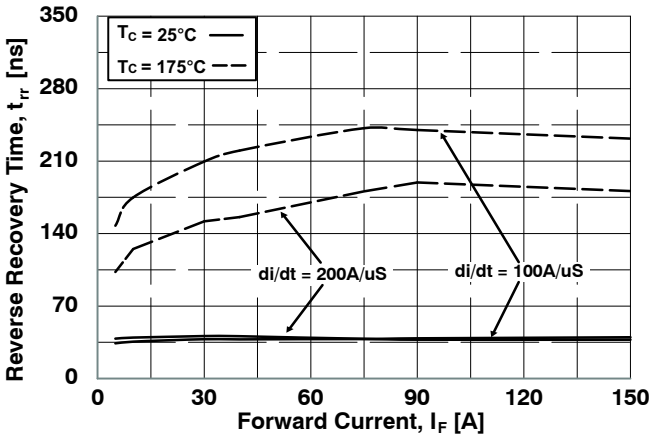



Figure 17. Reverse Recovery Time

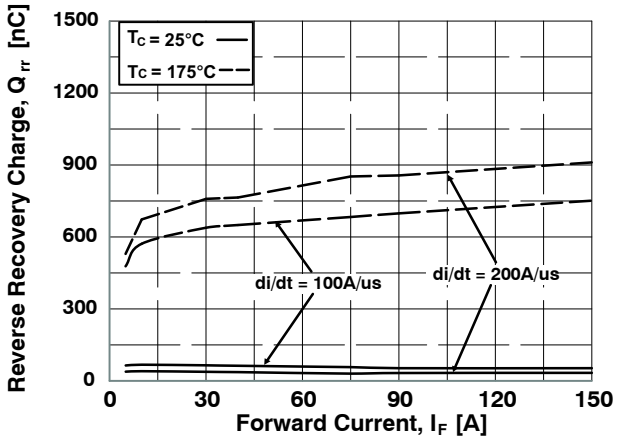



Figure 18. Stored Charge

## TYPICAL CHARACTERISTICS

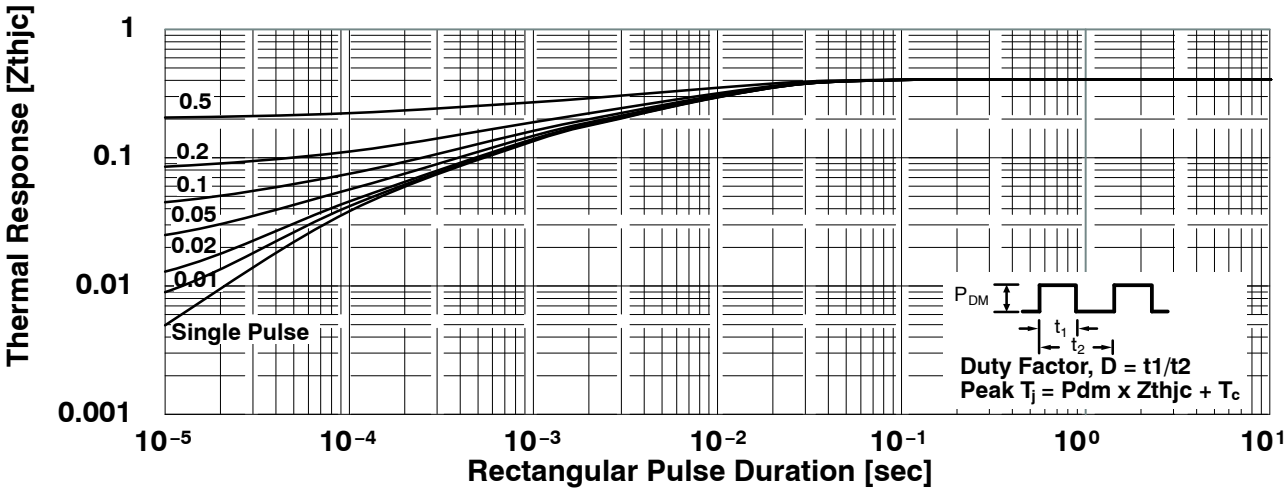



**Figure 19. Transient Thermal Impedance of IGBT**

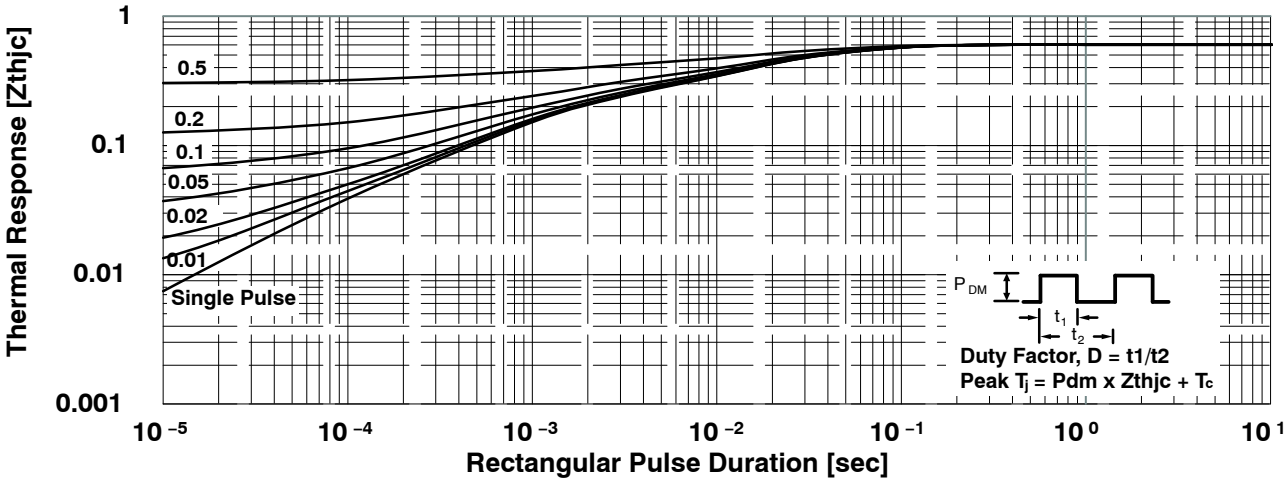
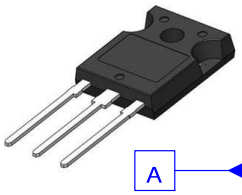
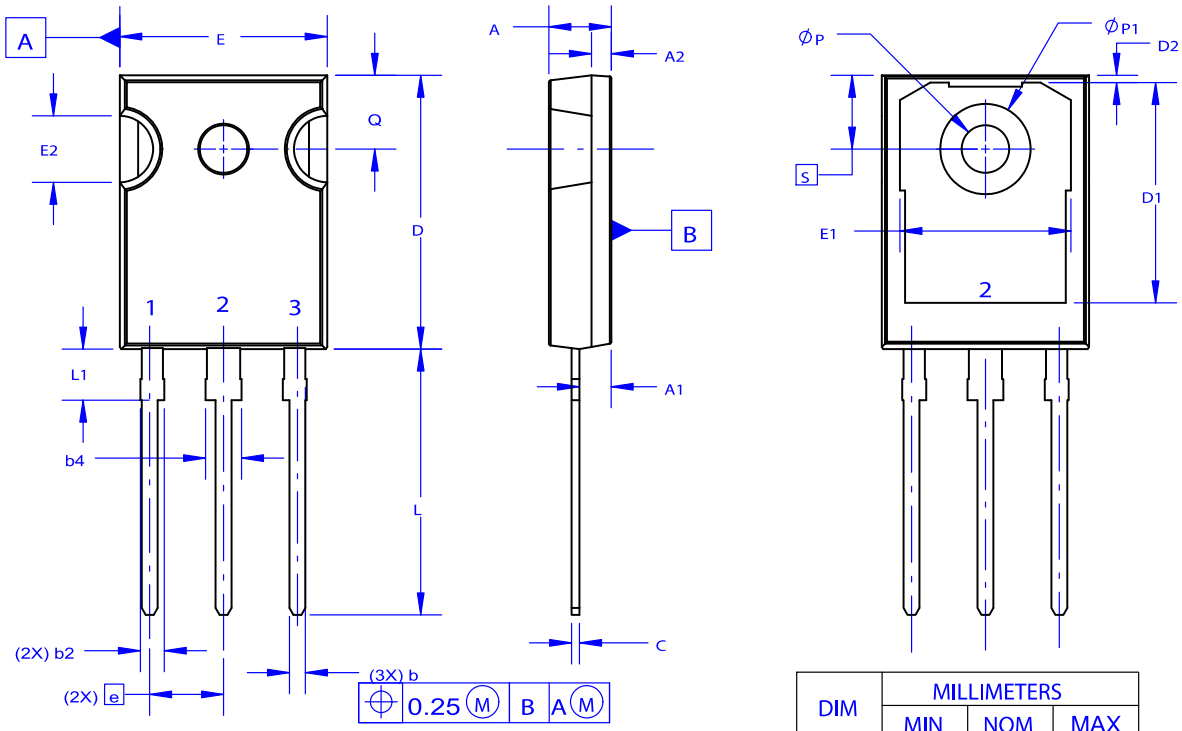



**Figure 20. Transient Thermal Impedance of Diode**

**TO−247−3LD**
CASE 340CX
ISSUE A

DATE 06 JUL 2020






NOTES: UNLESS OTHERWISE SPECIFIED.

A. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
B. ALL DIMENSIONS ARE IN MILLIMETERS.
C. DRAWING CONFORMS TO ASME Y14.5 - 2009.
D. DIMENSION A1 TO BE MEASURED IN THE REGION DEFINED BY L1.
E. LEAD FINISH IS UNCONTROLLED IN THE REGION DEFINED BY L1.

| DIM | MILLIMETERS | | |
|---|---|---|---|
| | MIN | NOM | MAX |
| A | 4.58 | 4.70 | 4.82 |
| A1 | 2.20 | 2.40 | 2.60 |
| A2 | 1.40 | 1.50 | 1.60 |
| D | 20.32 | 20.57 | 20.82 |
| E | 15.37 | 15.62 | 15.87 |
| E2 | 4.96 | 5.08 | 5.20 |
| e | ~ | 5.56 | ~ |
| L | 19.75 | 20.00 | 20.25 |
| L1 | 3.69 | 3.81 | 3.93 |
| ØP | 3.51 | 3.58 | 3.65 |
| Q | 5.34 | 5.46 | 5.58 |
| S | 5.34 | 5.46 | 5.58 |
| b | 1.17 | 1.26 | 1.35 |
| b2 | 1.53 | 1.65 | 1.77 |
| b4 | 2.42 | 2.54 | 2.66 |
| c | 0.51 | 0.61 | 0.71 |
| D1 | 13.08 | ~ | ~ |
| D2 | 0.51 | 0.93 | 1.35 |
| E1 | 12.81 | ~ | ~ |
| ØP1 | 6.60 | 6.80 | 7.00 |

## GENERIC MARKING DIAGRAM*


XXXXX = Specific Device Code
A = Assembly Location
Y = Year
WW = Work Week
G = Pb−Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb−Free indicator, “G” or microdot “ ▪”, may or may not be present. Some products may not follow the Generic Marking.

| | | |
|---|---|---|
| **DOCUMENT NUMBER:** | **98AON93302G** | Electronic versions are uncontrolled except when accessed directly from the Document Repository. Printed versions are uncontrolled except when stamped “CONTROLLED COPY” in red. |
| **DESCRIPTION:** | **TO−247−3LD** | **PAGE 1 OF 1** |

## ADDITIONAL INFORMATION

**TECHNICAL PUBLICATIONS**:
**Technical Library:** www.onsemi.com/design/resources/technical−documentation
**onsemi Website:** www.onsemi.com

**ONLINE SUPPORT**: www.onsemi.com/support
**For additional information, please contact your local Sales Representative at** www.onsemi.com/support/sales